## 2U half-size compact mainframe with 2 slots

- Maximum number of modules: 2
- Interface: USB, GPIB, LAN, RS232
- Handler interface: 4 channels
- Digital I/O: 8 bits


## Micro-current/ultra-high resistance meter modules for 4000

- Current measurement range: $\mathbf{1 0} \mathbf{f A}$ to $\mathbf{3 . 2} \mathbf{~ m A}$
- High-speed current measurement at 1.5 ms by integration method
- Voltage source: $\pm 200$ V (40051/40052)
+300 V, -100 V (40053/40054)

> GPIB USB LAN RS232

- Contact check: 0 to 100 pF with resolution of 0.1 pF
- Handler interface: INDEX, EOM, HI, GO, LO, NC



## 40002 Slot Modular Instrument

The 4000 is a 2 -slot modular instrument of 2 U half-size mainframe to which 2 units of 0.7 U half-size modules can be installed.
It is equipped with various interfaces; USB, GPIB, LAN and RS232, making it possible to build inspection systems for $R \& D$ or production lines of electronics components by connecting to a personal computer or programmable controller.
In addition, the 4-channel handler interface allows you timing control with automatic machines, and device selection according to measurement and judgment results by the modules.
In inspection lines, you can easily perform system setup or maintenance of modules that are mounted on system racks without removal such as module replacement, operation check via USB on the front panel.
Moreover, by using the digital I/O of 8 bits having a $5 \mathrm{~V} / 200 \mathrm{~mA}$ power supply, easy relay control and signal generation are available.


4000 Front Panel


4000 Rear Panel

## 40051/40052/40053/40054 IR Meter Units

The 40051, 40052, 40053 and 40054 IR meter units are to be mounted into the 2 -slots modular instrument 4000.
The 1-channel 40051 and 40053 and 2-channel 40052 and 40054 are integration-method IR meters, suitable for current measurement of high-capacity samples such as capacitors.
The current measurement range is from 10 fA to 3.2 mA , and the voltage source range is up to $\pm 200 \mathrm{~V} / 3.2 \mathrm{~mA}$ for the 40051 and 40052 , or up to +300 V or $-100 \mathrm{~V} / 3.2 \mathrm{~A}$ for the 40053 and 40054 . The resistance measurement range is between $312 \Omega$ to $3 \times 10^{16} \Omega$.
In addition, it has a contact check function (C.CHK) by capacity (C) measurement to judge the contact status of highresistance samples.
Moreover, the handler interface signals to be controlled from automatic machines in production lines are directly output to the rear connectors on the 4000 .


Handler interface timing and measurement time under the conditions of DC measurement mode by external trigger

[Measurement time]
INDEX and EOM times in DC mode ( $\mathrm{Td}=0.05 \mathrm{~ms}$ )

| Measurement time | Typical value | $\mathrm{Ti}=1 \mathrm{~ms}$ |
| :---: | :---: | :---: |
| INDEX time (From trigger input to falling edge of /INDEX) | integration time (Ti)+ +ms | 1.5 ms |
| Contact check ON | +1.5 ms | 3.0 ms |
| EOM time (From trigger input to falling edge of /EOM) | /INDEX + 0.25 ms | 1.75 ms |
| Resistance measurement | +0.06 ms | 1.81 ms |
| Comparison judgment | $+0.05 \mathrm{~ms}$ | 1.86 ms |
|  | Ti | $\alpha$ |
|  | 1/2/5 ms | 0.5/0.6/0.7 |
|  | 0.5/1 PLC | 1.6/1.6 |
|  | 100 ms | 12 |
|  | 200 ms | 22 |

INDEX and EOM times in fixed sweep mode: DC mode $+0.1 \mathrm{~ms}+$ Hold time (Th)

## 2 Slot Modular Instrument 4000 Specifications

Indicators (LEDs)
PON: Power ON
ERR: Error (Fan stopped, self-test error)

## Interface Specifications:

USB interface: USB 2.0 Full-Speed
(Front/Rear) Connector: Type B
USB POWER: Power: $+5 \mathrm{~V} / 1$ A max
(Front)
GPIB interface: $\quad$ Compliant to IEEE-488.1-1978
(Rear)

LAN interface:
(Rear)
RS232 interface:

Handler interface: Input:/TRIGGER, INTERLOCK
(Rear, 4 channels) Output:/INDEX, /EOM, /COMPLETE, /HI, /GO, /LO, /NO.CONTACT, /VS LIMIT, /ALARM
Input level: Hi ; +4 to +30 V , Lo; 0 to +0.8 V
Output level: Hi; 30 V max, Lo; 0.8 V max, sink; 50 mA max Connector: D-Sub 15 pin
Digital I/O:
Input/Output: 8 bits
(Rear)
Input level: Hi; +4 to +30 V , Lo; 0 to +0.8 V
Output level: Hi; 30 V max, Lo; 0.8 V max, sink: 50 mA max
Power supply: +5 V/200 mA
Connector: D-Sub 15 pin

## General Specifications

Operation environment: Temperature; $0^{\circ} \mathrm{C}$ to $+50^{\circ} \mathrm{C}$
Relative humidity; 85 \% or less with no condensation
Storage environment: Temperature; $-25^{\circ} \mathrm{C}$ to $+70^{\circ} \mathrm{C}$
Relative humidity; $85 \%$ or less with no condensation
Power supply: $\quad 100$ VAC to 240 VAC
Power frequency:
$50 \mathrm{~Hz} / 60 \mathrm{~Hz}$
Power consumption Mainframe with units: 150 VA or less (depending on the units) Mainframe only (without unit): 35 VA or less
Dimensions: $\quad$ Approx. $212(\mathrm{~W}) \times 88(\mathrm{H}) \times 400$ (D) mm (not including feet)
Mass: $\quad 3.3 \mathrm{~kg}$ or less (not including units and feet)
Supplied accessories

| Model | Quantity | Name |
| :--- | :---: | :--- |
| A01402 | 1 | Power supply cable |

Optional accessories

| Model | Name |
| :--- | :--- |
| A02263 | JIS standard, rack mount set (single) |
| A02264 | JIS standard, rack mount set (twin) |
| A02463 | EIA standard, rack mount set (single) |
| A02464 | EIA standard, rack mount set (twin) |
| A02039 | Panel mount set (single) |
| A02040 | Panel mount set (twin) |

## IR Meter Unit 40051/40052/40053/40054

## Specifications

All accuracy specifications are guaranteed for one year at a temperature of $23 \pm 5{ }^{\circ} \mathrm{C}$ and a relative humidity not exceeding 70 \%.

## Measurement Functions

1. DC current measurement

Integration time: 200 ms

| Range | Maximum display | Resolution | Accuracy $\pm(\%$ of reading + digits) |  | Temperature coefficient ${ }^{1}$ $\pm(\mathrm{ppm}$ of reading + digits) $/{ }^{\circ} \mathrm{C}$ |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | $\begin{aligned} & \text { At } 23^{\circ} \mathrm{C} \pm 5^{\circ} \mathrm{C}, \\ & \text { for one year } \end{aligned}$ | Within $\pm 3^{\circ} \mathrm{C}$ for 24 hrs after INTCAL |  |
| 300 pA | 319.999 pA | 1 fA | $0.65+120$ | $0.4+100$ | $600+15$ |
| 3 nA | 3.19999 nA | 10 fA | $0.65+35$ | $0.4+35$ | $600+2$ |
| 30 nA | 31.9999 nA | 100 fA | $0.5+25$ | $0.3+25$ | $600+1$ |
| 300 nA | 319.999 nA | 1 pA | $0.5+25$ | $0.3+25$ | $600+0.5$ |
| $3 \mu \mathrm{~A}$ | $3.19999 \mu \mathrm{~A}$ | 10 pA | $0.5+25$ | $0.3+25$ | $600+1$ |
| $30 \mu \mathrm{~A}$ | $31.9999 \mu \mathrm{~A}$ | 100 pA | $0.5+25$ | $0.3+25$ | $600+0.5$ |
| $300 \mu \mathrm{~A}$ | $319.999 \mu \mathrm{~A}$ | 1 nA | $0.5+21$ | $0.3+21$ | $600+0.5$ |
| 3 mA | 3.19999 mA | 10 nA | $0.5+22$ | $0.35+22$ | $600+0.5$ |

Input voltage drop:
$\pm 1.5 \mathrm{mV}+(50 \Omega \times$ measurement current) or less at input resistance $50 \Omega$
$\pm 1.5 \mathrm{mV}+(1.1 \mathrm{k} \Omega \times$ measurement current) or less and $\pm 0.6 \mathrm{~V}$ or less at input resistance $1 \mathrm{k} \Omega$ Input bias current: 100 fA or less
Settling time: Same time as the integration time (until the specified accuracies are satisfied.) Maximum allowable input current: 3.2 mA
NMRR: 60 dB or more (at $50 \mathrm{~Hz} / 60 \mathrm{~Hz} \pm 0.08 \%$ )
*1: At temperature of 0 to $50^{\circ} \mathrm{C}$ and relative humidity of $70 \%$ or less
$\pm 50 \mathrm{fA} /{ }^{\circ} \mathrm{C}$ is added to the digits item between $+40^{\circ} \mathrm{C}$ and $+50^{\circ} \mathrm{C}$.
2. Resistance value display (RM operation)
(Resistance value obtained by "voltage source value/current measurement value".
Values in [] are at input resistance $1 \mathrm{k} \Omega$.)

| Voltage source | Current measurement | Resistance measurement range |
| :---: | :---: | :---: |
| 1 V to 300 V | 10 fA to 3.2 mA | $312 \Omega$ to $3 \times 10^{16} \Omega$ |

Measurement accuracy:
$\pm($ (rdg item of current measurement range + setting item of voltage source range) + (digits item of voltage source range $\times$ resolution $\times 100 /$ source voltage value) + (resistance reading value $\times$ digits item of current measurement range $\times$ resolution $\times 100 /$ source voltage value) $) \%+50 \Omega[1.1 \mathrm{k} \Omega$ ]
Temperature coefficient:
$\pm($ (rdg item of current measurement range + setting item of voltage source range) + (digits item of voltage source range $\times$ resolution $\times 100$ source voltage value) + (resistance reading value $\times$ digits item of current measurement range $\times$ resolution $\times 100 /$ source voltage value) $) \% /{ }^{\circ} \mathrm{C}+5 \Omega /{ }^{\circ} \mathrm{C}\left[6 \Omega /{ }^{\circ} \mathrm{C}\right]$
Maximum display: 1 to 5 digits (1 to 9.9999)

Example of integration time 200 ms , input voltage $\pm 100 \mathrm{~V}$ and input resistance $50 \Omega$

| Current <br> range | Measurement <br> range $[\Omega]$ | Accuracy |  |
| :---: | :---: | :---: | :---: |
|  |  | At $23{ }^{\circ} \mathrm{C} \pm 5^{\circ} \mathrm{C}$, for one year | Within $\pm 3{ }^{\circ} \mathrm{C}$ for 24 hrs after INTCAL |
| 300 pA | $3.12 \times 10^{11}$ to $1 \times 10^{16}$ | $0.68+0.05+1.2 \times 10^{-13} \mathrm{Rm}+50 \Omega$ | $0.43+0.05+1 \times 10^{-13} \mathrm{Rm}+50 \Omega$ |
| 3 nA | $3.12 \times 10^{10}$ to $1 \times 10^{15}$ | $0.68+0.05+3.5 \times 10^{-13} \mathrm{Rm}+50 \Omega$ | $0.43+0.05+3.5 \times 10^{-13} \mathrm{Rm}+50 \Omega$ |
| 30 nA | $3.12 \times 10^{9}$ to $1 \times 10^{14}$ | $0.53+0.05+2.5 \times 10^{-12} \mathrm{Rm}+50 \Omega$ | $0.33+0.05+2.5 \times 10^{-12} \mathrm{Rm}+50 \Omega$ |
| 300 nA | $3.12 \times 10^{8}$ to $1 \times 10^{13}$ | $0.53+0.05+2.5 \times 10^{-11} \mathrm{Rm}+50 \Omega$ | $0.33+0.05+2.5 \times 10^{-11} \mathrm{Rm}+50 \Omega$ |
| $3 \mu \mathrm{~A}$ | $3.12 \times 10^{7}$ to $1 \times 10^{12}$ | $0.53+0.05+2.5 \times 10^{-10} \mathrm{Rm}+50 \Omega$ | $0.33+0.05+2.5 \times 10^{-10} \mathrm{Rm}+50 \Omega$ |
| $30 \mu \mathrm{~A}$ | $3.12 \times 10^{6}$ to $1 \times 10^{11}$ | $0.53+0.05+2.5 \times 10^{-9} \mathrm{Rm}+50 \Omega$ | $0.33+0.05+2.5 \times 10^{-9} \mathrm{Rm}+50 \Omega$ |
| $300 \mu \mathrm{~A}$ | $3.12 \times 10^{5}$ to $1 \times 10^{10}$ | $0.53+0.05+2.1 \times 10^{-8} \mathrm{Rm}+50 \Omega$ | $0.33+0.05+2.1 \times 10^{-8} \mathrm{Rm}+50 \Omega$ |
| 3 mA | $3.12 \times 10^{4}$ to $1 \times 10^{9}$ | $0.53+0.05+2.2 \times 10^{-7} \mathrm{Rm}+50 \Omega$ | $0.38+0.05+2.2 \times 10^{-7} \mathrm{Rm}+50 \Omega$ |

Rm : resistance reading value
3. Additional errors in DC current measurement

Additional error for each integration time other than 200 ms . For each integration time (IT), the following accuracies are added to the accuracies of the integration time of 200 ms
$\pm(\%$ of reading + digits)

| Integration time <br> (IT) | $1 \mathrm{~ms}, 2 \mathrm{~ms}$ |  | 5 ms |  | 0.5 PLC |  | 1 PLC |  | 100 ms |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Range | rdg | digits | rdg | digits | rdg | digits | rdg | digits | rdg | digits |
| 300 pA | 0 | 30 | 0 | 30 | 0 | 30 | 0 | 30 | 0 | 30 |
| 3 nA | 0 | 265 | 0 | 265 | 0 | 165 | 0 | 65 | 0 | 15 |
| 30 nA | 0.15 | 125 | 0.15 | 55 | 0.15 | 25 | 0.15 | 5 | 0 | 5 |
| 300 nA | 0.15 | 25 | 0 | 55 | 0 | 25 | 0 | 5 | 0 | 0 |
| $3 \mu \mathrm{~A}$ | 0 | 25 | 0 | 25 | 0 | 5 | 0 | 0 | 0 | 0 |
| $30 \mu \mathrm{~A}$ | 0 | 5 | 0 | 55 | 0 | 25 | 0 | 0 | 0 | 0 |
| $300 \mu \mathrm{~A}$ | 0 | 25 | 0 | 25 | 0 | 5 | 0 | 0 | 0 | 0 |
| 3 mA | 0 | 15 | 0 | 5 | 0 | 5 | 0 | 2 | 0 | 0 |

PLC: Power Line Cycle ( $50 \mathrm{~Hz}: 20 \mathrm{~ms}, 60 \mathrm{~Hz}: 16.67 \mathrm{~ms}$ )

Integration time by ICV method (Ti) against setting integration time (IT)

| Range | Setting integration time (IT) |  |  |  |  |  |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | 1 ms | 2 ms | 5 ms | 0.5 PLC | 1 PLC | 100 ms | 200 ms |  |  |  |  |  |  |
| 300 pA | 100 ms |  |  |  |  |  |  |  |  |  |  |  |  |
| 3 nA | 5 ms |  |  |  |  |  |  |  | 5 ms | 0.5 PLC | 1 PLC | 100 ms | 200 ms |
| 30 nA to $30 \mu \mathrm{~A}$ | 1 ms | 2 ms | 5 ms | 0.5 PLC | 1 PLC | 100 ms | 200 ms |  |  |  |  |  |  |
| $300 \mu \mathrm{~A}$ | 1 ms | 2 ms | 5 ms | 0.5 PLC | 1 PLC | $1 \mathrm{PLC} \times 4$ | $1 \mathrm{PLC} \times 8$ |  |  |  |  |  |  |
| 3 mA | 1 ms | 2 ms | $1 \mathrm{~ms} \times 2$ | $2 \mathrm{~ms} \times 2$ | $2 \mathrm{~ms} \times 4$ | $2 \mathrm{~ms} \times 20$ | $2 \mathrm{~ms} \times 40$ |  |  |  |  |  |  |

The expressions such as " $2 \mathrm{~ms} \times 2$ " indicate that measurement is performed by using the average of two measurements with integration time of 2 ms .

## Source Functions

- Voltage source

| Range | Maximum <br> display | Resolution | Accuracy <br> $\pm(\%$ of setting + digits $)$ | Temperature coefficient <br> $\pm\left(\mathrm{ppm}\right.$ of setting + digits) $/{ }^{\circ} \mathrm{C}$ |
| :---: | :---: | :---: | :---: | :---: |
| 30 V | $\pm 32.000 \mathrm{~V}$ | 1 mV | $0.03+6$ | $20+0.5$ |
| $200 \mathrm{~V}^{\cdot 2}$ | $\pm 200.00 \mathrm{~V}$ |  | $30.03+5$ | $20+0.5$ |
| $300 \mathrm{~V}^{\circ 2}$ | +300.00 V | 10 mV |  |  |
|  | -100.00 V |  |  |  |

[^0]*2: The 200 V range is for the 40051/40052 only and the 300 V range is for the $40053 / 40054$ only.

- Output noise

Peak to peak values under the following load conditions

| Range | Load resistance | DC to 100 Hz | DC to 10 kHz |
| :---: | :---: | :---: | :---: |
| 30 V | No load or <br> maximum load | 1 mV | 3 mV |
| $200 \mathrm{~V}^{+2}$ |  | 10 mV |  |
| $300 \mathrm{~V}^{.2}$ |  |  |  |

*2: The 200 V range is for the $40051 / 40052$ only and the 300 V range is for the $40053 / 40054$ only.

- Current limit

The difference between +IL and -IL must be 0.06 mA or higher.

| Range | Maximum <br> display | Resolution | Accuracy <br> $\pm(\%$ of setting + digits $)$ | Temperature coefficient <br> $\pm\left(\mathrm{ppm}\right.$ of setting + digits $/{ }^{\circ} \mathrm{C}$ | Setting range |
| :---: | :---: | :---: | :---: | :---: | :---: |
| 3 mA | 3.200 mA | $1 \mu \mathrm{~A}$ | $0.1+23$ | $30+0.6$ | 0.03 mA to 3.200 mA |

## Setting Time

Source delay time (Tds), Period (measurement cycle) (Tp), Measurement delay time (Td):

| Setting time | Resolution | Setting accuracy |
| :---: | :---: | :---: |
| 0.030 ms to 60.000 ms (Source delay) <br> 0.100 ms to 60.000 ms (Period) <br> 0.050 ms to 60.000 ms (Measurement delay) | $1 \mu \mathrm{~s}$ | $\pm(0.1$ \% + $10 \mu \mathrm{~s})$ |
| 60.01 ms to 600.00 ms | $10 \mu \mathrm{~s}$ |  |
| 600.1 ms to 6000.0 ms | $100 \mu \mathrm{~s}$ |  |
| 6001 ms to 59998 ms | 1 ms |  |
| Hold time (Th): |  |  |
| Setting time | Resolution | Setting accuracy |
| 0 ms to 6000.0 ms | 0.1 ms | $\pm(2 \%+2 \mathrm{~ms})$ |
| 6001 ms to 60000 ms | 1 ms |  |

## Source and Measurement Functions

## Source mode:

DC mode, Sweep mode
Fixed level sweep
1 to 1,000
Sweep repeat count:
Maximum number of sweep steps:
10,000 steps/channel
Measurement data buffer memory: 10,000 data/channel

Comparison operation: HI, GO, LO
Contact check function:

| Measurement range: | 0 to 100 pF |
| :--- | :--- |
| Measurement frequency: | $500 \mathrm{kHz}, 315 \mathrm{kHz}$ |
| Resolution: | $0.1 \mathrm{pF} / 500 \mathrm{kHz}, 0.2 \mathrm{pF} / 315 \mathrm{kHz}$ |
| Open Cal: | 0 pF to 90 pF |
| Maximum cable length: | TRIAX cable 3 m |

Measurement terminal: INPUT TRIAXIAL connector
LO Safety socket (40051/40053)
Voltage output terminal: VS Safety socket

Maximum input voltage/current between terminals:

|  | Internal shield | VS | LO | Chassis |
| :--- | :---: | :---: | :---: | :---: |
| INPUT | 3.2 mA | 3.2 mA | 3.2 mA | 3.2 mA |
| Internal shield |  | ${ }^{\circ}$ | short $^{* 3}$ | ${ }^{4}$ |
| VS |  |  | ${ }^{4}$ | ${ }^{4}$ |
| LO |  |  |  | ${ }^{4}$ |

*3: The internal shield is connected to the LO terminal.
*4: The chassis is connected to the LO or the VS terminal depending on the relay.
*5 at the terminal where no connection is made.
*5: $200 \mathrm{~V}(40051 / 40052),+300 \mathrm{~V}-100 \mathrm{~V}(40053 / 40054)$
Indicators (LEDs)
OPR Operate (output ON)
SMP Sampling indicator
HIG VS-GND connecting status
ERR Error (VS LIMIT, self test error, unit error)

## General Specifications

Operation environment: Temperature; $0^{\circ} \mathrm{C}$ to $+50^{\circ} \mathrm{C}$ Relative humidity; $85 \%$ or less with no condensation
Storage environment: Temperature; $-25^{\circ} \mathrm{C}$ to $+70^{\circ} \mathrm{C}$
Relative humidity; 85 \% or less with no condensation
Warm-up time $\quad 60$ minutes or longer (until the specified accuracies are satisfied.)
Power consumption 40051/40053: 7.5 VA or less, 40052/40054: 15 VA or less
Dimensions: $\quad$ Approx. $207(\mathrm{~W}) \times 26(\mathrm{H}) \times 365(\mathrm{D}) \mathrm{mm}$
Mass: $\quad 40051 / 40053: 0.8 \mathrm{~kg}$ or less, $40052 / 40054: 1.0 \mathrm{~kg}$ or les

Optional accessories

| Model | Description |
| :--- | :--- |
| A01009 | TRIAX- TRIAX cable |
| A01239 | High-voltage TRIAX- TRIAX cable |
| A01010 | TRIAX-alligator cable |
| A01011 | TRIAX- BNC cable |
| A04201 | TRIAX J- TRIAX J adapter |
| A04202 | TRIAX-J - BNC-P 1 adapter (inside-outside) |
| A04203 | TRIAX-J - BNC-P 2 adapter (outside-outside) |
| A04204 | BNC-J - TRIAX-P 1 adapter (outside-inside) |
| A04205 | BNC-J - TRIAX-P 2 adapter ((outside-(inside+outside)) |
| A04206 | TRIAX-J - BNC-P 3 adapter ((inside+outside)-outside) |
| A04207 | BNC-J - M-P |
| A04208 | TRIAX-J receptacle |

- Please read through the operation manual carefully before using the products.
- All specifications are subject to change without notice.


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[^0]:    Settling time (until the final value $\pm 0.1 \%$ is reached): 3.5 ms or less ( 200 V ), $4.1 \mathrm{~ms}(300 \mathrm{~V}$ ) Maximum allowable input voltage: $\pm 200 \mathrm{~V}$ peak (40051/40052), $+300 \mathrm{~V}-100 \mathrm{~V}$ peak (40053/40054) Maximum capacitance load: $1000 \mu \mathrm{~F}$

